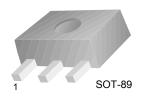


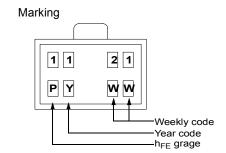
KSB1121 PNP Epitaxial Planar Silicon Transistor

High Current Driver Applications

- · Low Collector-Emitter Saturation Voltage
- · Large Current Capacity
- · Fast Switching Speed
- · Complement to KSD1621



1. Base 2. Collector 3. Emitter



Absolute Maximum Ratings T_a = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
V _{CBO}	Collector-Base Voltage	-30	V
V _{CEO}	Collector-Emitter Voltage	-25	V
V_{EBO}	Emitter-Base Voltage	-6	V
I _C	Collector Current	-2	A
P _C P _C *	Collector Power Dissipation	500 1.3	mW W
T_J	Junction Temperature	150	°C
T _{STG}	Storage Temperature	-55 ~ 150	°C

^{*} Mounted on Ceramic Board (250mm² x 0.8mm)

Electrical Characteristics T_a = 25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
BV _{CBO}	Collector-Base Breakdown Voltage	$I_C = -10\mu A, I_E = 0$	-30			V
BV _{CEO}	Collector-Emitter Breakdown Voltage	$I_C = -1 \text{mA}, I_B = 0$	-25			V
BV _{EBO}	Emitter-Base Breakdown Voltage	$I_E = -10\mu A, I_C = 0$	-6			V
I _{CBO}	Collector Cut-off Current	V _{CB} = -20V, I _E = 0			-100	nA
I _{EBO}	Emitter Cut-off Current	$V_{BE} = -4V, I_{C} = 0$			-100	nA
h _{FE1} h _{FE2}	DC Current Gain	$V_{CE} = -2V, I_{C} = -0.1A$ $V_{CE} = -2V, I_{C} = -1.5A$	100 65		560	
V _{CE} (sat)	Collector-Emitter Saturation Voltage	$I_C = -1.5A$, $I_B = -75mA$		-0.35	-0.6	V
V _{BE} (sat)	Base-Emitter Saturation Voltage	$I_C = -1.5A$, $I_B = -75mA$		-0.85	-1.2	V

Electrical Characteristics (continued) Ta = 25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
f _T	Current Gain Bandwidth Product	V _{CE} = -10V, I _C = -50mA		150		MHz
C _{ob}	Output Capacitance	V _{CB} = -10V, I _E = 0, f = 1MHz		32		pF
t _{ON}	Turn On Time *	V _{CC} = -12V, V _{BE} = -5V		60		ns
t _{STG}	Storage Time *	$I_{B1} = -I_{B2} = -25\text{mA}$ $I_{C} = -500\text{mA}, R_{L} = 24\Omega$		350		ns
t _F	Fall time *	10300111A, INL - 2432		25		ns

h_{FE} Classification

Classification	R	S	Т	U
h _{FE1}	100 ~ 200	140 ~ 280	200 ~ 400	280 ~ 560

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
1121	KSB1121	SOT-89	13"	-	4,000

Typical Performance Characteristics

Figure 1. Static Characteristic

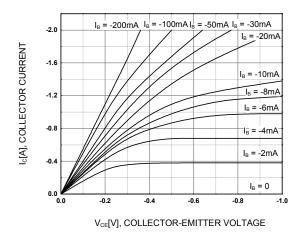


Figure 2. DC Current Gain

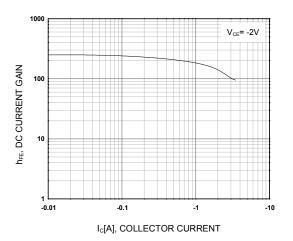


Figure 3. Collector-Emitter Saturation Voltage

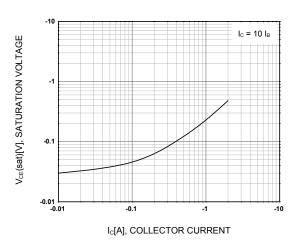


Figure 4. Base-Emitter On Voltage

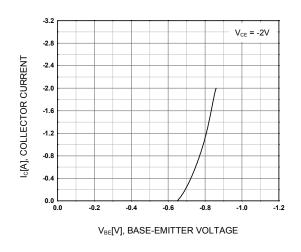


Figure 5. Collector Output Capacitance

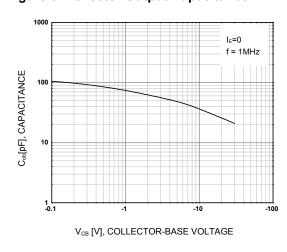
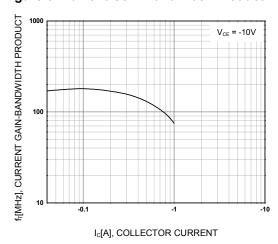
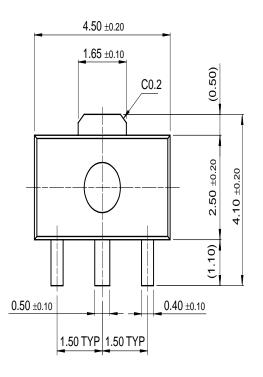


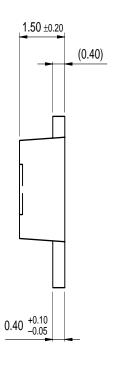
Figure 6. Current Gain Bandwidth Product

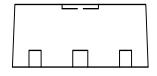


Mechanical Dimensions

SOT-89







Dimensions in Millimeters

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